

Search Notes

Application/Control No.

10/767,296

Examiner

Michael Thaler

Applicant(s)/Patent under
Reexamination

YAN, JOHN Y.

Art Unit

3731

SEARCHED

Class	Subclass	Date	Examiner
623	1.15		
	1.4		
	1.42		
	1.39		
	1.44	6/27/2007	MT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner